



## 18. TEST PHOTOGRAPHS

See following Attached Pages for setup photographs.

<b>FCC ID:</b> A3LSMG965U	 <b>PCTEST</b> ENGINEERING LABORATORY, INC.	<b>HAC (RF EMISSIONS) TEST REPORT</b>		<b>Approved by:</b> Quality Manager
<b>Filename:</b> 1M1711060289-13-R1.A3L	<b>Test Dates:</b> 11/06/2017 - 12/11/2017	<b>DUT Type:</b> Portable Handset	Page 106 of 108	

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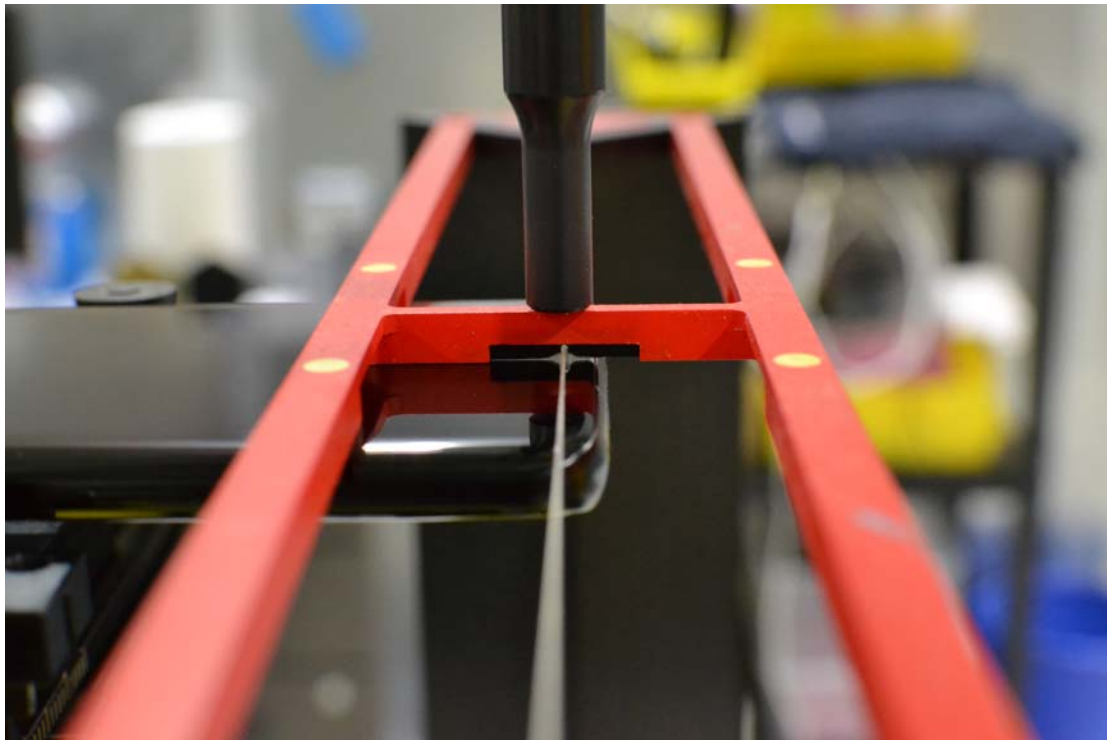
REV 3.1.M

09/14/2017



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**Figure 18-1**  
**Ear Reference Point HAC Phantom Alignment**



**Figure 18-2**  
**HAC Phantom Plane Alignment**

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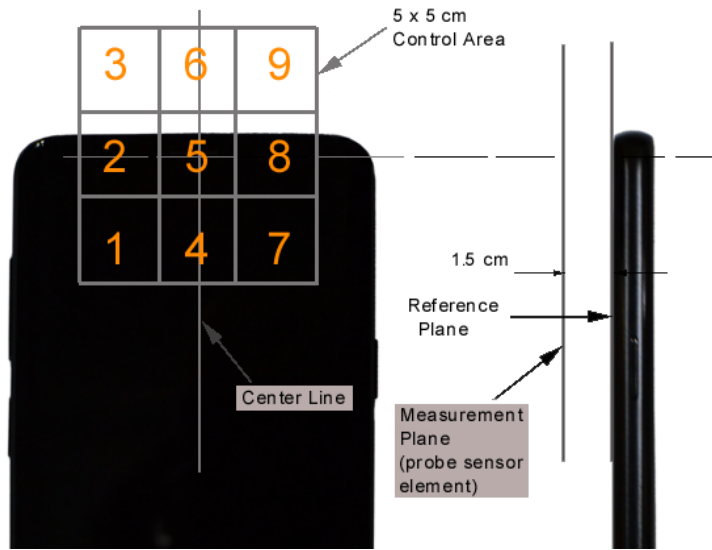




Figure 18-3 5x5 Scan grid above WD



Figure 18-4 E-Field WD Scan overlay

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